# Notice of References Cited Application/Control No. 10/615,731 Examiner Michael La Villa Applicant(s)/Patent Under Reexamination SUGIHARA ET AL. Page 1 of 1

### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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### Applicant(s)/Patent Under Application/Control No. Reexamination 10/615,731 SUGIHARA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Michael La Villa 1775 **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 428/667 US-6,635,361 B1 10-2003 Sugihara et al. Α US-8 US-. С US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ US-L US-FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) W

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